

Search Notes

Application/Control No.

10/526,760

Examiner

Brian J. Davis

Applicant(s)/Patent under
Reexamination

BUEHLMAYER ET AL.

Art Unit

1621

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
structure searches on STN to gauge search size (see search history printout)	1/19/2007	BJD
inventor name searches on PALM	1/19/2007	BJD